

Notice of References Cited	Application/Control No. 10/523,994	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Hoang Tran	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,814,406	09-1998	Newmoyer, Kerry	428/379
*	B	US-2003/0128938 a1	07-2003	Caveney, Jack E.	385/81
*	C	US-2003/0158309	08-2003	Ono et al.	524/261
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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